

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/021,592 | Applicant(s)/Patent Under Reexamination MORRIS ET AL. | |
| | Examiner A Elamin | Art Unit 2116 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-2004/0153802 A1 | 08-2004 | Kudo et al. | 714/030 |
| | B | US-2004/0073780 A1 | 04-2004 | Roth et al. | 712/227 |
| | C | US-6,918,058 B2 | 07-2005 | Miura et al. | 714/30 |
| | D | US-6,868,510 B1 | 03-2005 | Nozu, Takashi | 714/48 |
| | E | US-6,760,834 B2 | 07-2004 | Roche et al. | 712/202 |
| | F | US-6,553,506 B1 | 04-2003 | Hijikata et al. | 713/501 |
| | G | US-6,415,393 B2 | 07-2002 | Satoh, Shuji | 714/30 |
| | H | US-6,067,638 A | 05-2000 | Benitz et al. | 714/37 |
| | I | US-6,067,407 A | 05-2000 | Wadsworth et al. | 709/224 |
| | J | US-6,052,806 A | 04-2000 | Beat, Robert | 714/718 |
| | K | US-5,781,721 A | 07-1998 | Hayes et al. | 714/42 |
| | L | US-5,530,804 A | 06-1996 | Edgington et al. | 714/30 |
| | M | US-4,575,792 | 03-1986 | Keeley, James W. | 714/42 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.